

<b>Notice of References Cited</b>	Application/Control No. 10/040,628	Applicant(s)/Patent Under Reexamination WAKU ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,216,462 A	08-1980	McGrath et al.	600/301
*	B	US-5,594,786 A	01-1997	Chaco et al.	379/93.09
*	C	US-5,689,229 A	11-1997	Chaco et al.	340/286.07
*	D	US-5,740,800 A	04-1998	Hendrickson et al.	600/300
*	E	US-5,748,907 A	05-1998	Crane, Harold E.	705/2
*	F	US-5,751,837 A	05-1998	Watanabe et al.	382/131
*	G	US-5,764,159 A	06-1998	Neftel, Frederic	340/870.09
*	H	US-5,822,544 A	10-1998	Chaco et al.	705/2
*	I	US-6,047,259 A	04-2000	Campbell et al.	705/3
*	J	US-6,259,355 B1	07-2001	Chaco et al.	340/286.07
*	K	US-6,500,122 B1	12-2002	Washburn et al.	600/443
*	L	US-6,647,328 B2	11-2003	Walker, Richard C.	701/36
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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